


<b>Search Notes</b> 	<b>Application/Control No.</b> 10564654	<b>Applicant(s)/Patent Under Reexamination</b> ZHUN, ZHONG
	<b>Examiner</b> Meless N Zewdu	<b>Art Unit</b> 2617

SEARCHED			
Class	Subclass	Date	Examiner
455	24, 41.2, 435.1-435.3, 434, 450-451, 452.1-452.2, 455, 464, 466, 509-517, 524-525, 550.1, 556.2, 561	5/28/2009	M.Z.
370	328-329, 341-343, 345, 347, 349-350, 442-448, 450, 458-459, 461, 463, 395.65, 901, 908, 913, 915	5/28/2009	M.Z.
367	118-129, 138		M.Z.

SEARCH NOTES		
Search Notes	Date	Examiner
Searched in EAST: US-PGUB; USPAT; USOCR; EPO; JPO; DERWENT AND IBM_TDB	5/28/2009	M.Z.
Searched by: Assignee; Inventor; Keywords and Class-subclass.	5/28/2009	M.Z.
For more detail: please refer to the attached search history	5/28/2009	M.Z.

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/Meless N Zewdu/ Primary Examiner.Art Unit 2617
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